

FSB50250UD

Motion SPM® 5 Series

Features

- UL Certified No. E209204 (UL1557)
- 500 V R_{DS(on)} = 4.2 Ω(Max) FRFET MOSFET 3-Phase Inverter with Gate Drivers and Protection
- Built-In Bootstrap Diodes Simplify PCB Layout
- Separate Open-Source Pins from Low-Side MOSFETs for Three-Phase Current-Sensing
- Active-HIGH Interface, Works with 3.3 / 5 V Logic, Schmitt-trigger Input
- · Optimized for Low Electromagnetic Interference
- HVIC for Gate Driving and Under-Voltage Protection
- Isolation Rating: 1500 V_{rms} / min.
- RoHS Compliant

Applications

 3-Phase Inverter Driver for Small Power AC Motor Drives

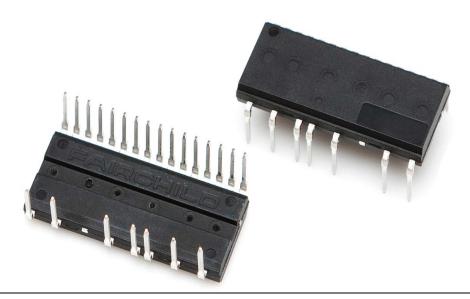


Related Source

 AN-9082 - Motion SPM5 Series Thermal Performance by Contact Pressure

General Description

The FSB50250UD is an advanced Motion SPM® 5 module providing a fully-featured, high-performance inverter output stage for AC Induction, BLDC and PMSM motors. These modules integrate optimized gate drive of the built-in MOSFETs (FRFET® technology) to minimize EMI and losses, while also providing multiple on-module protection features including under-voltage lockouts. The built-in, high-speed HVIC requires only a single supply voltage and translates the incoming logic-level gate inputs to the high-voltage, high-current drive signals required to properly drive the module's internal MOSFETs. Separate open-source MOSFET terminals are available for each phase to support the widest variety of control algorithms.



Package Marking & Ordering Information

Device	Device Marking	Package	Packing Type	Quantity
FSB50250UD	FSB50250UD	FSB50250UD SPM5R-023 Rai		15

Absolute Maximum Ratings

Inverter Part (each MOSFET unless otherwise specified.)

Symbol	Parameter	Conditions	Rating	Unit
V _{DSS}	Drain-Source Voltage of Each MOSFET		500	V
*I _{D 25}	Each MOSFET Drain Current, Continuous	T _C = 25°C	1.1	Α
*I _{D 80}	Each MOSFET Drain Current, Continuous	$T_C = 80^{\circ}C$	0.8	Α
*I _{DP}	Each MOSFET Drain Current, Peak	T _C = 25°C, PW < 100 μs	2.8	Α
*P _D	Maximum Power Dissipation	T _C = 25°C, For Each MOSFET	13	W

Control Part (each HVIC unless otherwise specified.)

Symbol	Parameter	Conditions	Rating	Unit
V _{CC}	Control Supply Voltage	Applied Between V _{CC} and COM	20	V
V _{BS}	High-side Bias Voltage	Applied Between V _B and V _S	20	V
V _{IN}	Input Signal Voltage	Applied Between IN and COM	-0.3 ~ V _{CC} + 0.3	V

Bootstrap Diode Part (each bootstrap diode unless otherwise specified.)

Symbol	Parameter Conditions		Rating	Unit
V _{RRMB}	Maximum Repetitive Reverse Voltage		500	V
* I _{FB}	Forward Current	$T_C = 25^{\circ}C$	0.5	Α
* I _{FPB}	Forward Current (Peak)	T _C = 25°C, Under 1ms Pulse Width	2.0	А

Thermal Resistance

Symbol	Parameter	Conditions	Rating	Unit
$R_{ heta JC}$	Junction to Case Thermal Resistance	Each MOSFET under Inverter Operating Condition (1st Note 1)	9.3	°C/W

Total System

Symbol	Parameter	Parameter Conditions		Unit
TJ	Operating Junction Temperature		-40 ~ 150	°C
T _{STG}	Storage Temperature		-40 ~ 125	°C
V _{ISO}	Isolation Voltage	60 Hz, Sinusoidal, 1 Minute, Connect Pins to Heat Sink Plate	1500	V_{rms}

1st Notes

- 1. For the measurement point of case temperature $T_{\mbox{\scriptsize C}},$ please refer to Figure 4.
- 2. Marking " $\mbox{\scriptsize *}$ " is calculation value or design factor.

Pin descriptions

Pin Number	Pin Name	Pin Description
1	СОМ	IC Common Supply Ground
2	V _{B(U)}	Bias Voltage for U Phase High Side MOSFET Driving
3	V _{CC(U)}	Bias Voltage for U Phase IC and Low Side MOSFET Driving
4	IN _(UH)	Signal Input for U Phase High-Side
5	IN _(UL)	Signal Input for U Phase Low-Side
6	V _{S(U)}	Bias Voltage Ground for U Phase High Side MOSFET Driving
7	V _{B(V)}	Bias Voltage for V Phase High Side MOSFET Driving
8	V _{CC(V)}	Bias Voltage for V Phase IC and Low Side MOSFET Driving
9	IN _(VH)	Signal Input for V Phase High-Side
10	IN _(VL)	Signal Input for V Phase Low-Side
11	V _{S(V)}	Bias Voltage Ground for V Phase High Side MOSFET Driving
12	V _{B(W)}	Bias Voltage for W Phase High Side MOSFET Driving
13	V _{CC(W)}	Bias Voltage for W Phase IC and Low Side MOSFET Driving
14	IN _(WH)	Signal Input for W Phase High-Side
15	IN _(WL)	Signal Input for W Phase Low-Side
16	V _{S(W)}	Bias Voltage Ground for W Phase High Side MOSFET Driving
17	Р	Positive DC-Link Input
18	U	Output for U Phase
19	N _U	Negative DC-Link Input for U Phase
20	N _V	Negative DC-Link Input for V Phase
21	V	Output for V Phase
22	N _W	Negative DC-Link Input for W Phase
23	W	Output for W Phase

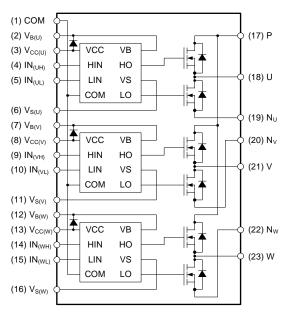


Figure 1. Pin Configuration and Internal Block Diagram (Bottom View)

1st Notes:

^{3.} Source terminal of each low-side MOSFET is not connected to supply ground or bias voltage ground inside Motion SPM® 5 product. External connections should be made as indicated in Figure 3.

Electrical Characteristics ($T_J = 25$ °C, $V_{CC} = V_{BS} = 15$ V unless otherwise specified.)

Inverter Part (each MOSFET unless otherwise specified.)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
BV _{DSS}	Drain - Source Breakdown Voltage	V _{IN} = 0 V, I _D = 1 mA (2nd Note 1)		-	-	V
$\Delta BV_{DSS}/$ ΔT_{J}	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.53	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{IN} = 0 V, V _{DS} = 500 V		-	250	μΑ
R _{DS(on)}	Static Drain - Source Turn-On Resistance	V _{CC} = V _{BS} = 15 V, V _{IN} = 5 V, I _D = 0.5 A		3.5	4.2	Ω
V _{SD}	Drain - Source Diode Forward Voltage	V _{CC} = V _{BS} = 15V, V _{IN} = 0 V, I _D = -0.5 A		-	1.2	V
t _{ON}			-	1050	-	ns
t _{OFF}		$V_{PN} = 300 \text{ V}, V_{CC} = V_{BS} = 15 \text{ V}, I_{D} = 0.5 \text{ A}$	-	850	-	ns
t _{rr}	Switching Times	$V_{IN} = 0 \text{ V} \leftrightarrow 5 \text{ V}$, Inductive Load L = 3 mH High- and Low-Side MOSFET Switching	-	170	-	ns
E _{ON}		(2nd Note 2)	-	40	-	μJ
E _{OFF}			-	10	-	μJ
RBSOA	Reverse Bias Safe Operating Area	Oper- $V_{PN} = 400 \text{ V}, V_{CC} = V_{BS} = 15 \text{ V}, I_D = I_{DP}, V_{DS} = BV_{DSS}, T_J = 150^{\circ}\text{C}$ High- and Low-Side MOSFET Switching (2nd Note 3)		Full	Square	

Control Part (each HVIC unless otherwise specified.)

Symbol	Parameter		Conditions	Min	Тур	Max	Unit
I _{QCC}	Quiescent V _{CC} Current	V _{CC} = 15 V, V _{IN} = 0 V	Applied Between V _{CC} and COM	-	-	160	μΑ
I _{QBS}	Quiescent V _{BS} Current	V _{BS} = 15 V, V _{IN} = 0 V	Applied Between $V_{B(U)}$ - U, $V_{B(V)}$ - V, $V_{B(W)}$ - W	-	-	100	μА
UV _{CCD}	Low-Side Under-Voltage	V _{CC} Under-Voltage Protection Detection Level		7.4	8.0	9.4	V
UV _{CCR}	Protection (Figure 8)	V _{CC} Under-Voltage Protection Reset Level		8.0	8.9	9.8	V
UV _{BSD}	High-Side Under-Voltage	V _{BS} Under-Voltage Protection Detection Level		7.4	8.0	9.4	V
UV _{BSR}	Protection (Figure 9)	V _{BS} Under-Voltage	Protection Reset Level	8.0	8.9	9.8	V
V _{IH}	ON Threshold Voltage	Logic HIGH Level	Applied between IN and COM	2.0	-	-	V
V _{IL}	OFF Threshold Voltage	Logic LOW Level	Applied between IN and COM	-	-	8.0	V
I _{IH}	Input Pigg Current	V _{IN} = 5V	Applied between IN and COM	-	10	20	μΑ
I _{IL}	Input Bias Current	V _{IN} = 0V	Applied between IN and COM	-	-	2	μА

Bootstrap Diode Part (each bootstrap diode unless otherwise specified.)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{FB}	Forward Voltage	I _F = 0.1 A, T _C = 25°C (2nd Note 4)	-	2.0	-	V
t _{rrB}	Reverse Recovery Time	$I_F = 0.1 \text{ A, T}_C = 25^{\circ}\text{C}$	-	80	-	ns

2nd Notes:

- 1. BV_{DSS} is the absolute maximum voltage rating between drain and source terminal of each MOSFET inside Motion SPM[®] 5 product. V_{PN} should be sufficiently less than this value considering the effect of the stray inductance so that V_{PN} should not exceed BV_{DSS} in any case.
- 2. t_{ON} and t_{OFF} include the propagation delay of the internal drive IC. Listed values are measured at the laboratory test condition, and they can be different according to the field applications due to the effect of different printed circuit boards and wirings. Please see Figure 5 for the switching time definition with the switching test circuit of Figure 6.
- 3. The peak current and voltage of each MOSFET during the switching operation should be included in the Safe Operating Area (SOA). Please see Figure 6 for the RBSOA test circuit that is same as the switching test circuit.
- 4. Built-in bootstrap diode includes around 15 Ω resistance characteristic. Please refer to Figure 2.

Recommended Operating Condition

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
V _{PN}	Supply Voltage	Applied Between P and N	-	300	400	V
V _{CC}	Control Supply Voltage	Applied Between V _{CC} and COM	13.5	15.0	16.5	V
V _{BS}	High-Side Bias Voltage	Applied Between V _B and V _S	13.5	15.0	16.5	V
V _{IN(ON)}	Input ON Threshold Voltage	Applied Between IN and COM	3.0	-	V _{CC}	V
V _{IN(OFF)}	Input OFF Threshold Voltage		0	-	0.6	V
t _{dead}	Blanking Time for Preventing Arm-Short	$V_{CC} = V_{BS} = 13.5 \sim 16.5 \text{ V}, T_{J} \le 150^{\circ}\text{C}$	1.0	-	-	μS
f _{PWM}	PWM Switching Frequency	T _J ≤ 150°C	-	15	=	kHz

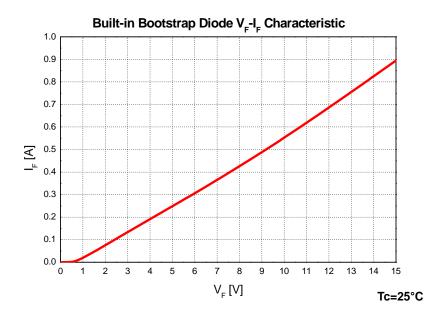
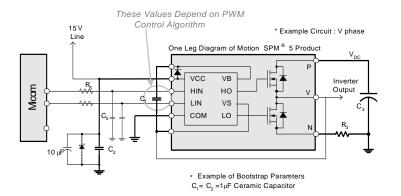


Figure 2. Built-in Bootstrap Diode Characteristics (Typical)



HIN	LIN	Output	Note
0	0	Z	Both FRFET Off
0	1	0	Low side FRFET On
1	0	VDC	High side FRFET On
1	1	Forbidden	Shoot through
Open	Open	Z	Same as (0,0)

Figure 3. Recommended MCU Interface and Bootstrap Circuit with Parameters

3rd Notes

- 1. Parameters for bootstrap circuit elements are dependent on PWM algorithm. For 15 kHz of switching frequency, typical example of parameters is shown above.
- 2. RC-coupling (R₅ and C₆) and C₄ at each input of Motion SPM 5 product and MCU (Indicated as Dotted Lines) may be used to prevent improper signal due to surge-noise.
- Bold lines should be short and thick in PCB pattern to have small stray inductance of circuit, which results in the reduction of surge-voltage. Bypass capacitors such as C₁, C₂ and C₃ should have good high-frequency characteristics to absorb high-frequency ripple-current.

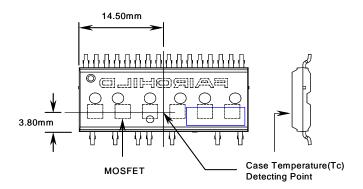


Figure 4. Case Temperature Measurement

3rd Notes:

4. Attach the thermocouple on top of the heat-sink of SPM 5 package (between SPM 5 package and heatsink if applied) to get the correct temperature measurement.

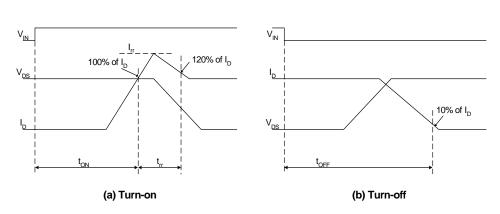


Figure 5. Switching Time Definitions

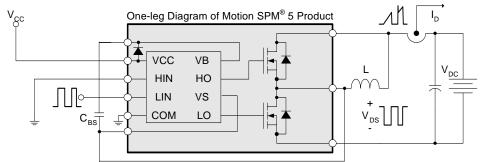


Figure 6. Switching and RBSOA (Single-pulse) Test Circuit (Low-side)

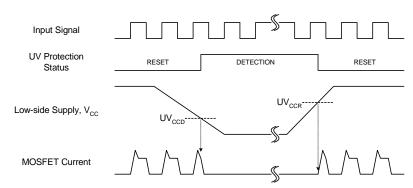


Figure 7. Under-Voltage Protection (Low-Side)

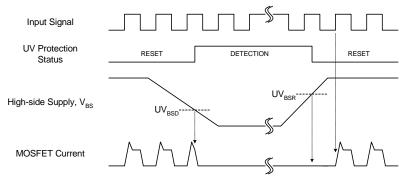


Figure 8. Under-Voltage Protection (High-Side)

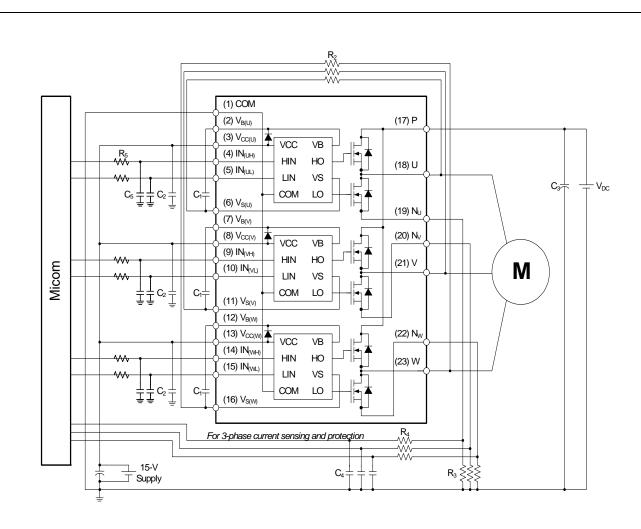
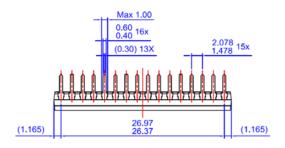


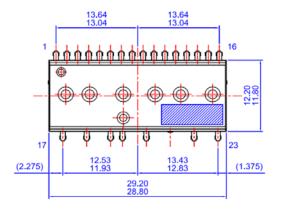
Figure 9. Example of Application Circuit

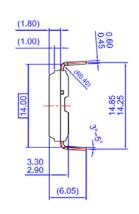
4th Notes:

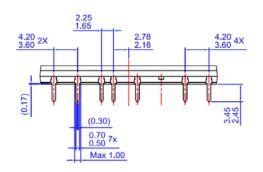
- 1. About pin position, refer to Figure 1.
- $2. \ RC\text{-coupling } (R_5 \text{ and } C_5, R_4 \text{ and } C_6) \text{ and } C_4 \text{ at each input of Motion SPM}^{\underline{0}} \ 5 \text{ product and MCU are useful to prevent improper input signal caused by surge-noise.}$
- 3. The voltage-drop across R₃ affects the low-side switching performance and the bootstrap characteristics since it is placed between COM and the source terminal of the low-side MOSFET. For this reason, the voltage-drop across R₃ should be less than 1 V in the steady-state.
- 4. Ground-wires and output terminals, should be thick and short in order to avoid surge-voltage and malfunction of HVIC.
- 5. All the filter capacitors should be connected close to Motion SPM 5 product, and they should have good characteristics for rejecting high-frequency ripple current.

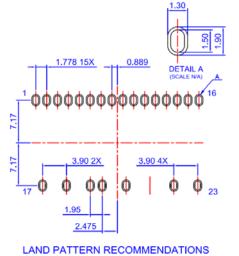
Detailed Package Outline Drawings











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